

FCC REPORT

Applicant: Shenzhen Aratek Biometrics Technology Co., Ltd.

Address of Applicant: 2F, T2-A Building, ShenZhen Software Park, South Area, Hi-Tech Park, Shenzhen, Guangdong, China

Equipment Under Test (EUT)

Product Name: BA8200-T, BA8200

Model No.: BA8200-T, BA8200

FCC ID: 2AGUJBA8200

Applicable standards: FCC CFR Title 47 Part 15 Subpart C Section 15.225

Date of sample receipt: 15 Jun., 2020

Date of Test: 16 Jun., to 08 Sep., 2020

Date of report issue: 09 Sep., 2020

Test Result: PASS*

* In the configuration tested, the EUT complied with the standards specified above.

Authorized Signature:



Bruce Zhang
Laboratory Manager

This report details the results of the testing carried out on one sample. The results contained in this test report do not relate to other samples of the same product and does not permit the use of the CCIS product certification mark. The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report.

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2 Version

Version No.	Date	Description
00	09 Sep., 2020	Original

Tested by: Yao Wu
Test Engineer

Date: 09 Sep., 2020

Reviewed by: Winner Zhang
Project Engineer

Date: 09 Sep., 2020

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4 Test Summary

Test Item	Section in CFR 47	Result
Antenna requirement	15.203	Pass
Field strength of the fundamental signal	15.225 (a)	Pass
Spurious emissions	15.225(d)& 15.209	Pass
20dB Bandwidth	15.215(c)	Pass
Frequency tolerance	15.225 (e)	Pass
Conducted Emission	15.207	Pass
<i>Remark:</i> 1. Pass: The EUT complies with the essential requirements in the standard. 2. The cable insertion loss used by "RF Output Power" and other conduction measurement items is 0.5dB (provided by the customer).		
Test Method:	ANSI C63.4-2014 ANSI C63.10-2013	

5 General Information

5.1 Client Information

Applicant:	Shenzhen Aratek Biometrics Technology Co., Ltd.
Address:	2F, T2-A Building, ShenZhen Software Park, South Area, Hi-Tech Park, Shenzhen, Guangdong, China
Manufacturer/ Factory :	Aratek Biometrics Technology Co., Ltd.
Address:	2F, T2-A Building, ShenZhen Software Park, South Area, Hi-Tech Park, Shenzhen, Guangdong, China

5.2 General Description of E.U.T.

Product Name:	BA8200-T, BA8200					
Model No.:	BA8200-T, BA8200					
Operation Frequency:	13.56MHz					
Channel numbers:	1					
Modulation type:	ASK					
Antenna Type:	Induction Coil Antenna					
AC adapter:	Model: 2K36WG-1200300W2 Input: AC100-240V, 50/60Hz, 0.8A Output: DC 12.0V, 3A					
Remark:	The No.: BA8200-T and BA8200 were identical inside, the electrical circuit design, layout, components used and internal wiring, with only difference that BA8200 only has facial recognition and RFID. However, BA8200-T contains facial recognition, fingerprint module, RFID and temperature module					
		Model				
	Item [↗]	Number [↗]	Camera [↗]	Fingerprint [↗]	RFID [↗]	Temperature module [↗]
	1 [↗]	BA8200 [↗]	1080P Dual HDR Camera with fill light, ↓ 105dB wide dynamic [↗]	None [↗]	ISO14443 A/B, MIFARE [↗]	None [↗]
	2 [↗]	BA8200-T [↗]	1080P Dual HDR Camera with fill light, ↓ 105dB wide dynamic [↗]	Optical Press [↗]	ISO14443 A/B, MIFARE [↗]	Infrared Temp Module [↗]
	We pre-scanned the BA8200-T and BA8200, and found that the BA8200-T is in worse condition, so the report only reflects the worse mode data					
Test Sample Condition:	The test samples were provided in good working order with no visible defects.					

5.3 Test mode

Transmitting mode:	Keep the EUT in transmitting mode with modulation		
Remark	During the test, pre-scan BA8200-T and BA8200, found BA8200-T was worse case. The report only reflects the worst mode.		
Pre-Test Mode:			
CCIS has verified the construction and function in typical operation, The EUT was placed on three different polar directions; i.e. X axis, Y axis, Z axis. which was shown in this test report and defined as follows:			
Axis	X	Y	Z
Field Strength(dBuV/m)	64.11	60.38	59.76
Final Test Mode:			
According to ANSI C63.10 standards, the test results are both the “worst case” and “worst setup”: Y axis (see the test setup photo).			

5.4 Description of Support Units

Manufacturer	Description	Model	Serial Number	FCC ID/DoC
N/A	N/A	N/A	N/A	N/A

5.5 Measurement Uncertainty

Parameters	Expanded Uncertainty
Conducted Emission (9kHz ~ 30MHz)	±1.60 dB (k=2)
Radiated Emission (9kHz ~ 30MHz)	±3.12 dB (k=2)
Radiated Emission (30MHz ~ 1000MHz)	±4.32 dB (k=2)

5.6 Additions to, deviations, or exclusions from the method

No

5.7 Laboratory Facility

The test facility is recognized, certified, or accredited by the following organizations:

● **FCC - Designation No.: CN1211**

Shenzhen Zhongjian Nanfang Testing Co., Ltd. has been accredited as a testing laboratory by FCC(Federal Communications Commission). The test firm Registration No. is 727551.

● **ISED – CAB identifier.: CN0021**

The 3m Semi-anechoic chamber of Shenzhen Zhongjian Nanfang Testing Co., Ltd. has been Registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 10106A-1.

● **A2LA - Registration No.: 4346.01**

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005 General requirements for the competence of testing and calibration laboratories. The test scope can be found as below link: <https://portal.a2la.org/scopepdf/4346-01.pdf>

5.8 Laboratory Location

Shenzhen Zhongjian Nanfang Testing Co., Ltd.
Address: No.110~116, Building B, Jinyuan Business Building, Xixiang Road,
Bao'an District, Shenzhen, Guangdong, China
Tel: +86-755-23118282, Fax: +86-755-23116366
Email: info@ccis-cb.com, Website: <http://www.ccis-cb.com>

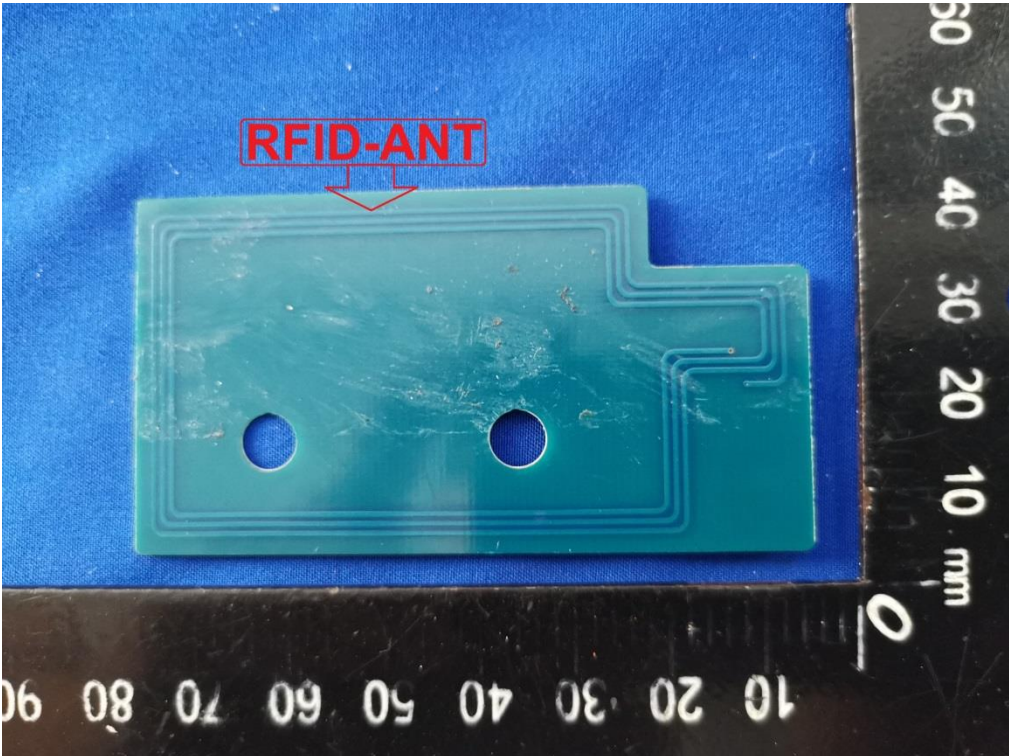
5.9 Test Instruments list

Radiated Emission:					
Test Equipment	Manufacturer	Model No.	Serial No.	Cal. Date (mm-dd-yy)	Cal. Due date (mm-dd-yy)
3m SAC	SAEMC	9m*6m*6m	966	07-22-2017	07-21-2020
Loop Antenna	SCHWARZBECK	FMZB1519B	044	03-07-2020	03-06-2021
BiConiLog Antenna	SCHWARZBECK	VULB9163	497	03-07-2020	03-06-2021
Horn Antenna	SCHWARZBECK	BBHA9120D	916	03-07-2020	03-06-2021
Horn Antenna	SCHWARZBECK	BBHA9120D	1805	06-22-2017	06-21-2020
				06-21-2020	06-20-2023
Horn Antenna	SCHWARZBECK	BBHA 9170	BBHA9170582	11-18-2019	11-17-2020
EMI Test Software	AUDIX	E3	Version: 6.110919b		
Pre-amplifier	HP	8447D	2944A09358	03-07-2020	03-06-2021
Pre-amplifier	CD	PAP-1G18	11804	03-07-2020	03-06-2021
Spectrum analyzer	Rohde & Schwarz	FSP30	101454	03-05-2020	03-04-2021
Spectrum analyzer	Rohde & Schwarz	FSP40	100363	11-18-2019	11-17-2020
EMI Test Receiver	Rohde & Schwarz	ESRP7	101070	03-05-2020	03-04-2021
Cable	ZDECL	Z108-NJ-NJ-81	1608458	03-07-2020	03-06-2021
Cable	MICRO-COAX	MFR64639	K10742-5	03-07-2020	03-06-2021
Cable	SUHNER	SUCOFLEX100	58193/4PE	03-07-2020	03-06-2021
RF Switch Unit	MWRFTTEST	MW200	N/A	N/A	N/A
Test Software	MWRFTTEST	MTS8200	Version: 2.0.0.0		

Conducted Emission:					
Test Equipment	Manufacturer	Model No.	Serial No.	Cal. Date (mm-dd-yy)	Cal. Due date (mm-dd-yy)
EMI Test Receiver	Rohde & Schwarz	ESCI	101189	03-05-2020	03-04-2021
Pulse Limiter	SCHWARZBECK	OSRAM 2306	9731	03-05-2020	03-04-2021
LISN	CHASE	MN2050D	1447	03-05-2020	03-04-2021
LISN	Rohde & Schwarz	ESH3-Z5	8438621/010	07-21-2017	07-20-2020
Cable	HP	10503A	N/A	03-05-2020	03-04-2021
EMI Test Software	AUDIX	E3	Version: 6.110919b		

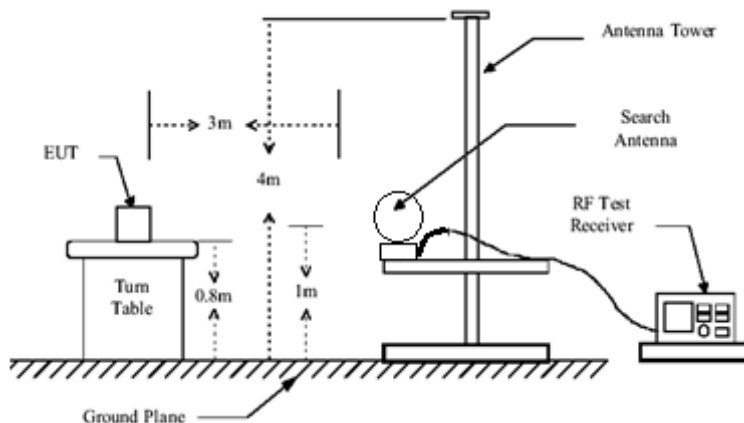
6 Test results and Measurement Data

6.1 Antenna requirement

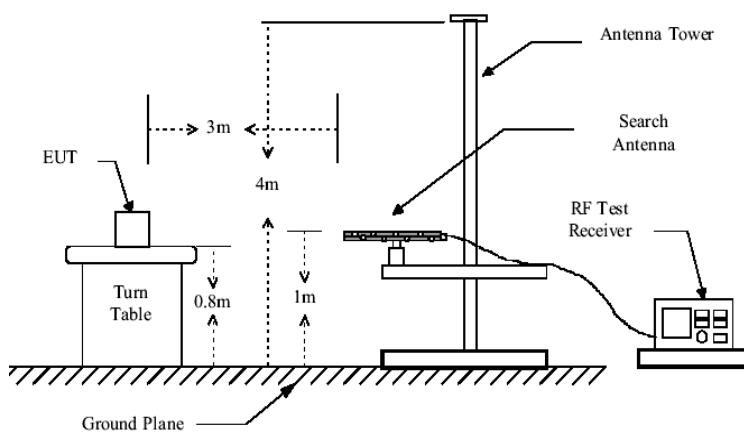
Standard requirement:	FCC Part15 C Section 15.203
15.203 requirement: An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator, the manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited.	
E.U.T Antenna:	
The EUT make use of an Induction coil antenna.	
	

6.2 Radiated Emission

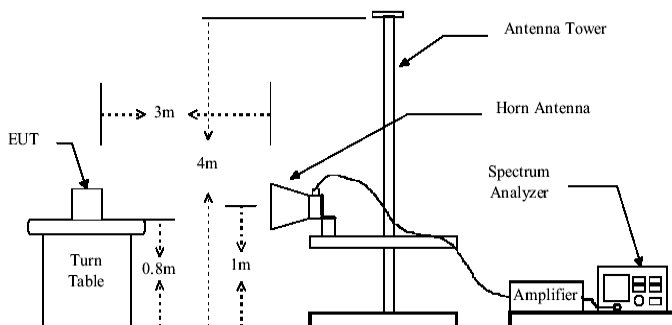
Test Requirement:	FCC Part15 C Section 15.225(a) and 15.209				
TestFrequencyRange:	9 kHz to 1000MHz				
Test site:	Measurement Distance: 3m(Semi-Anechoic Chamber)				
Receiver setup:	Frequency	Detector	RBW	VBW	Remark
	9kHz-150kHz	Quasi-peak	200Hz	600Hz	Quasi-peak Value
	150kHz-30MHz	Quasi-peak	9kHz	30kHz	Quasi-peak Value
	30MHz-1GHz	Quasi-peak	120kHz	300KHz	Quasi-peak Value
	Above 1GHz	Peak	1MHz	3MHz	Peak Value
Limit: (Field strength of the fundamental signal)	Frequency		Limit (uV/m @30m)		Limit (dBuV/m @3m)
	13.553MHz-13.567MHz		15848		124.0
	13.410MHz-13.553MHz & 13.567MHz-13.710MHz		334		90.5
	13.110MHz-13.410MHz & 13.710MHz-14.010MHz		106		80.5
	Remark: Per FCC part 15.31, when performing measurements at a distance which is closer than specified, the field strength results shall be extrapolated to the specified distance by using the square of an inverse linear distance extrapolation factor (i.e., 40 dB/decade) in conjunction with the slant-range distance defined in §15.3(hh) of this part.				
Limit: (Spurious Emissions)	Frequency (MHz)		Limit (uV/m @3m)		Distance (m)
	0.009-0.490		2400/F(kHz)		300
	0.490-1.705		24000/F(kHz)		30
	1.705-30		30		30
	30-88		100		3
	88-216		150		3
	216-960		200		3
	Above 1GHz		500		3
Test Procedure:	<p>a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter semi-anechoic chamber. The table was rotated 360 degrees to determine the position of the highest radiation.</p> <p>b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.</p> <p>c. The antenna height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.</p> <p>d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotating table was turned from 0 degrees to 360 degrees to find the maximum reading.</p> <p>e. The test-receiver system was set to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.</p> <p>f. If the emission level of the EUT in peak mode was 10dB lower than the limit specified, then testing could be stopped and the peak values of the EUT would be reported. Otherwise the emissions that did not have 10dB margin would be re-tested one by one using peak, quasi-peak or average method as specified and then reported in a data sheet.</p>				
Test setup:	9kHz-30MHz				



30MHz-1GHz



Above 1GHz

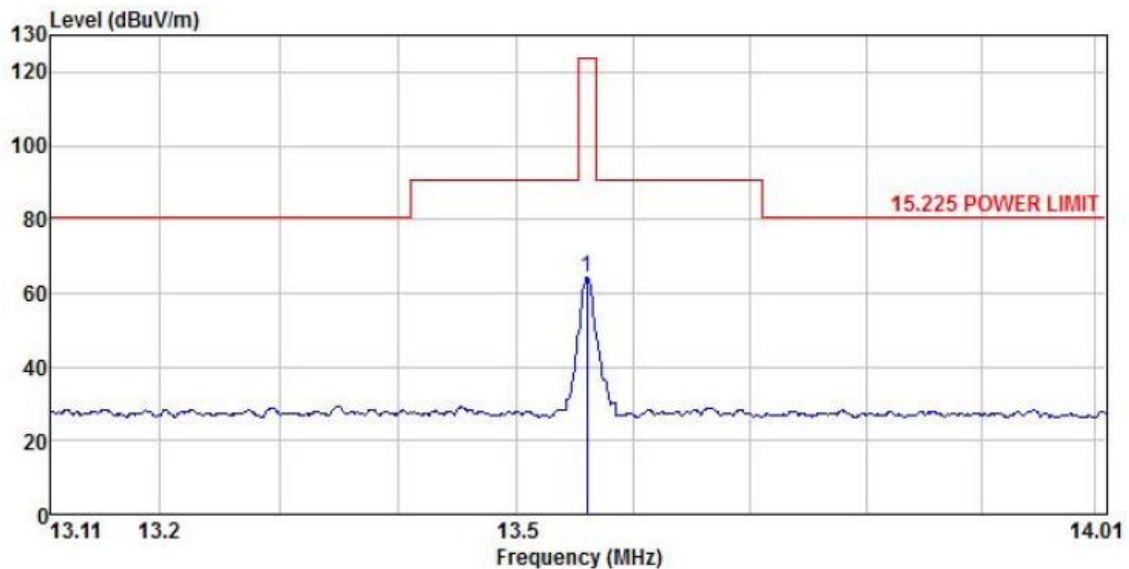


Test Instruments:	Refer to section 5.9 for details
Test mode:	Refer to section 5.3 for details
Test results:	Pass

Measurement Data:

Field Strength of fundamental signal:

Product Name:	BA8200-T	Product Model:	BA8200-T
Test By:	Yaro	Test mode:	RFID Tx mode
Test Voltage:	AC 120/60Hz	Environment:	Temp: 24℃ Humi: 57%



	Freq	Read Level	Antenna Factor	Cable Loss	Aux Factor	Preamp Factor	Level	Limit Line	Over Limit	Remark
	MHz	dBuV	dB/m	dB	dB	dB	dBuV/m	dBuV/m	dB	
1	13.560	44.11	19.59	0.41	0.00	0.00	64.11	124.00	-59.89	

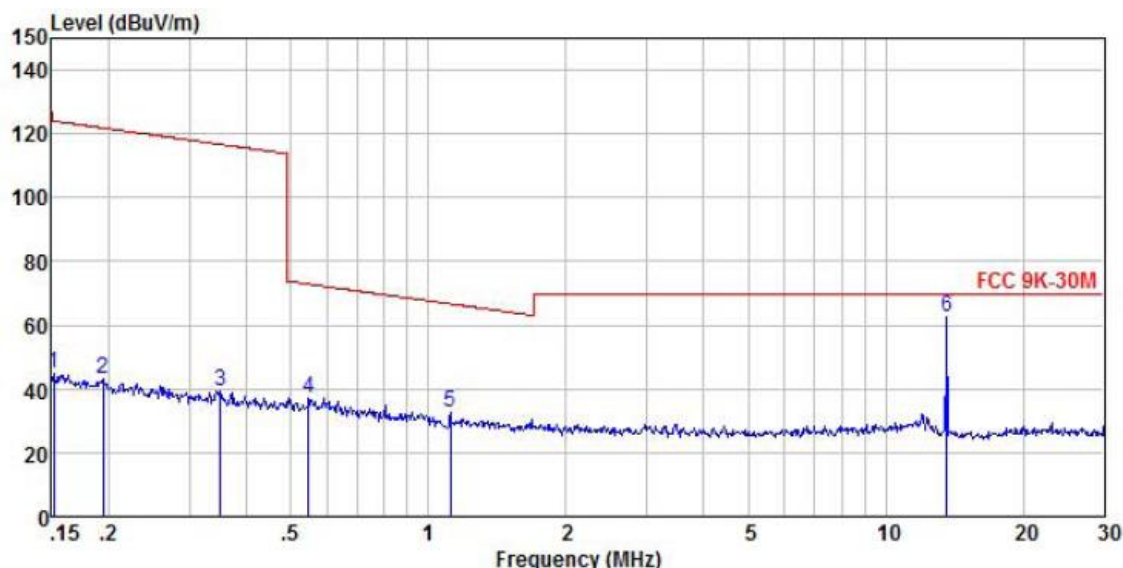
Remark:

1. Final Level = Receiver Read level + Antenna Factor + Cable Loss – Preamplifier Factor.

Spurious Emissions:

Test frequency range: 9 kHz- 30 MHz

Product Name:	BA8200-T	Product Model:	BA8200-T
Test By:	Yaro	Test mode:	RFID Tx mode
Test Frequency:	150 kHz ~ 30 MHz	Polarization:	Vertical
Test Voltage:	AC 120/60Hz	Environment:	Temp: 24°C Humi: 57%

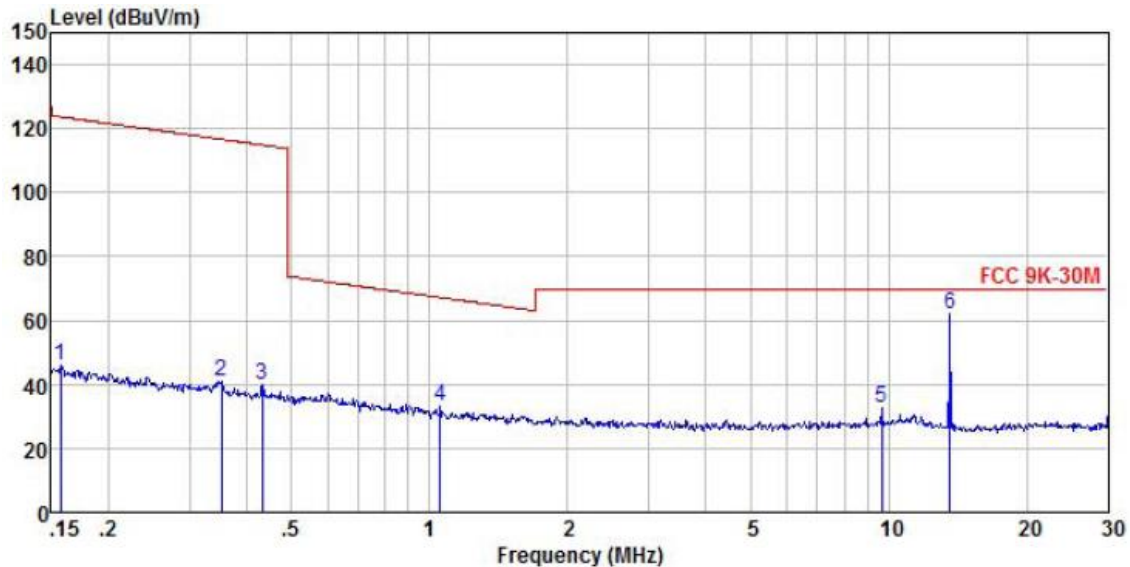


	Freq	Read Level	Antenna Factor	Cable Loss	Aux Factor	Preamplifier Factor	Level	Limit Line	Over Limit	Remark
	MHz	dBuV	dB/m	dB	dB	dB	dBuV/m	dBuV/m	dB	
1	0.152	24.51	20.20	0.03	0.00	0.00	44.74	124.01	-79.27	
2	0.194	22.81	20.33	0.04	0.00	0.00	43.18	121.84	-78.66	
3	0.350	18.80	20.62	0.06	0.00	0.00	39.48	116.72	-77.24	
4	0.546	16.07	20.76	0.10	0.00	0.00	36.93	72.86	-35.93	
5	1.117	11.83	20.49	0.17	0.00	0.00	32.49	66.66	-34.17	
6	13.623	42.67	19.57	0.42	0.00	0.00	62.66	69.50	-6.84	

Remark:

1. Final Level = Receiver Read level + Antenna Factor + Cable Loss – Preamplifier Factor.
2. The emission levels of 9 kHz~150 kHz are background noise and very lower than the limit, not show in test report.

Product Name:	BA8200-T	Product Model:	BA8200-T
Test By:	Yaro	Test mode:	RFID Tx mode
Test Frequency:	150 kHz ~ 30 MHz	Polarization:	Horizontal
Test Voltage:	AC 120/60Hz	Environment:	Temp: 24℃ Humi: 57%



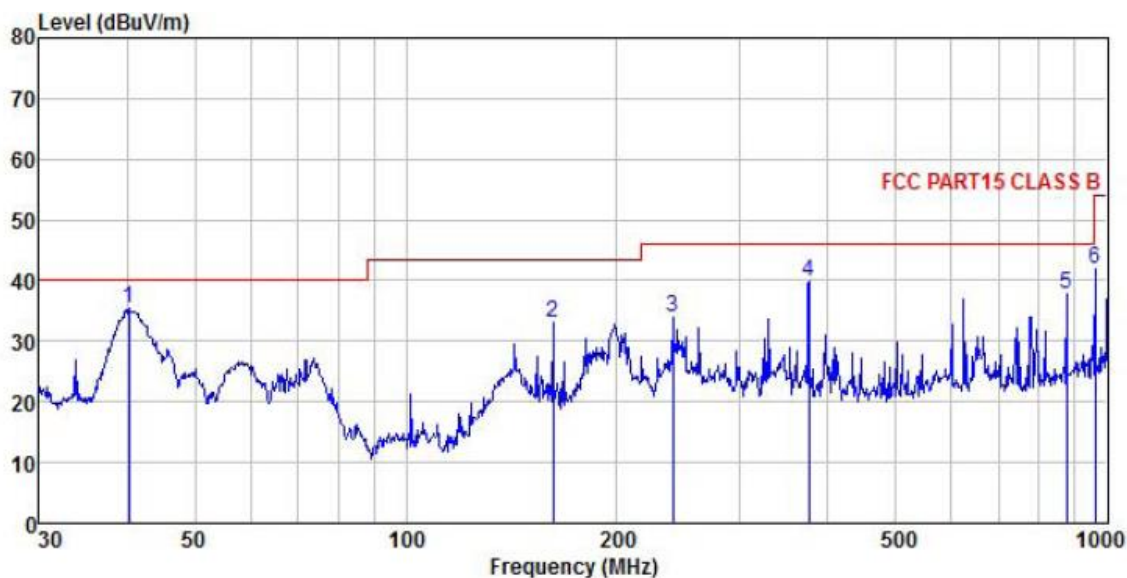
	Freq	ReadAntenna	Cable	Aux Preamp		Level	Limit	Over	Remark
	MHz	Level	Factor	Loss	Factor	Factor	Line	Limit	
		dBuV	dB/m	dB		dB	dBuV/m	dBuV/m	dB
1	0.157	25.43	20.22	0.03	0.00	0.00	45.68	123.69	-78.01
2	0.352	20.43	20.63	0.06	0.00	0.00	41.12	116.68	-75.56
3	0.433	18.84	20.73	0.07	0.00	0.00	39.64	114.88	-75.24
4	1.054	12.40	20.50	0.17	0.00	0.00	33.07	67.17	-34.10
5	9.654	12.14	20.27	0.35	0.00	0.00	32.76	69.50	-36.74
6	13.623	41.90	19.57	0.42	0.00	0.00	61.89	69.50	-7.61

Remark:

1. Final Level = Receiver Read level + Antenna Factor + Cable Loss – Preamplifier Factor.
2. The emission levels of 9 kHz~150 kHz are background noise and very lower than the limit, not show in test report.

Test frequency range: 30MHz-1000MHz

Product Name:	BA8200-T	Product Model:	BA8200-T
Test By:	Yaro	Test mode:	RFID Tx mode
Test Frequency:	30 MHz ~ 1 GHz	Polarization:	Vertical
Test Voltage:	AC 120/60Hz	Environment:	Temp: 24°C Humi: 57%

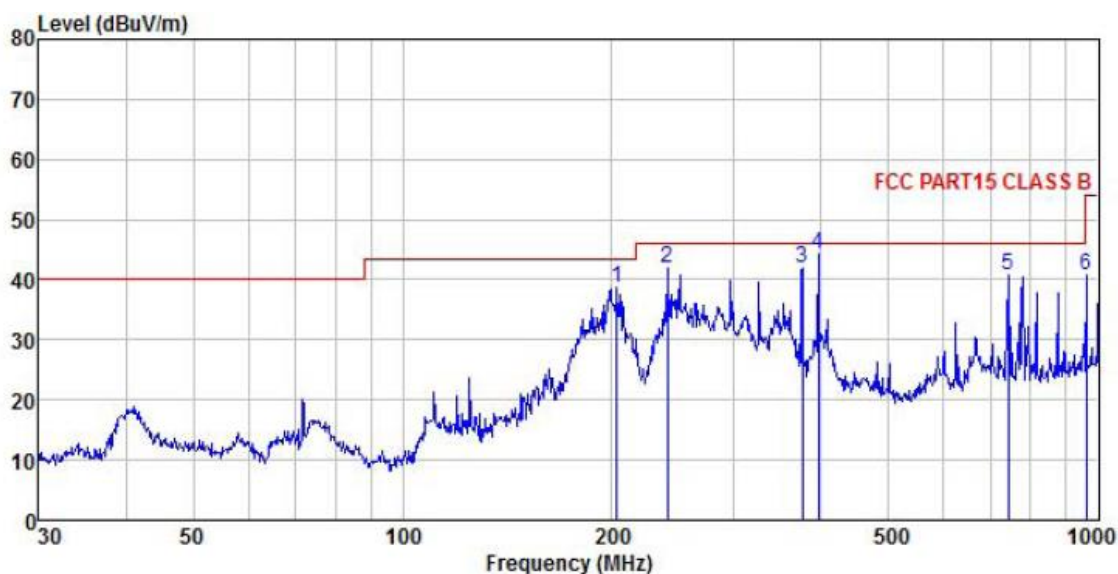


	Freq	ReadAntenna	Cable	Aux	Preamp	Level	Limit	Over	Remark
	MHz	Level	Factor	Loss	Factor	Factor	dBuV/m	dBuV/m	dB
		dBuV	dB/m	dB		dB			
1	40.276	52.08	12.81	0.35	0.00	29.90	35.34	40.00	-4.66 QP
2	162.041	45.96	15.54	0.64	0.00	29.12	33.02	43.50	-10.48 QP
3	239.987	43.29	18.46	0.76	0.00	28.59	33.92	46.00	-12.08 QP
4	375.939	48.49	18.96	0.96	0.00	28.68	39.73	46.00	-6.27 QP
5	875.247	42.39	22.00	1.45	0.00	27.94	37.90	46.00	-8.10 QP
6	962.162	45.20	22.88	1.57	0.00	27.65	42.00	54.00	-12.00 QP

Remark:

1. Final Level = Receiver Read level + Antenna Factor + Cable Loss – Preamplifier Factor.
2. The emission levels of other frequencies are very lower than the limit and not show in test report.
3. The Aux Factor is a notch filter switch box loss, this item is not used.

Product Name:	BA8200-T	Product Model:	BA8200-T
Test By:	Yaro	Test mode:	RFID Tx mode
Test Frequency:	30 MHz ~ 1 GHz	Polarization:	Horizontal
Test Voltage:	AC 120/60Hz	Environment:	Temp: 24°C Humi: 57%

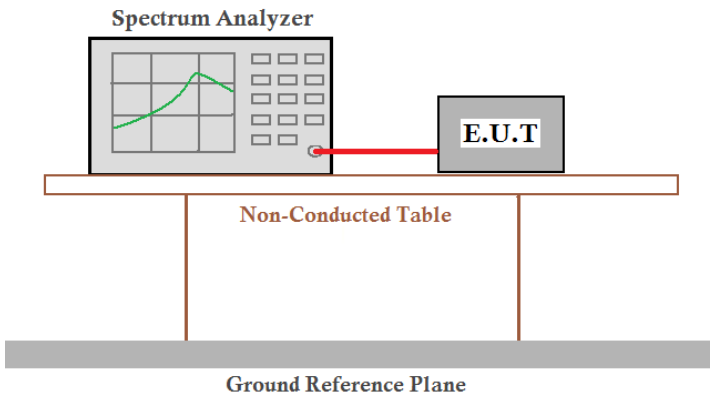


	Freq	ReadAntenna	Cable	Aux Preamp	Level	Limit	Over	Remark
	MHz	Level	Factor	Loss	Factor	Level	Line	
		dBuV	dB/m	dB	dB	dBuV/m	dBuV/m	dB
1	203.523	48.45	18.32	0.72	0.00	28.81	38.68	43.50 -4.82 QP
2	239.987	51.30	18.46	0.76	0.00	28.59	41.93	46.00 -4.07 QP
3	375.939	50.70	18.96	0.96	0.00	28.68	41.94	46.00 -4.06 QP
4	396.242	53.09	19.08	0.99	0.00	28.76	44.40	46.00 -1.60 QP
5	742.259	47.30	20.59	1.35	0.00	28.51	40.73	46.00 -5.27 QP
6	962.162	43.97	22.88	1.57	0.00	27.65	40.77	54.00 -13.23 QP

Remark:

1. Final Level = Receiver Read level + Antenna Factor + Cable Loss – Preamplifier Factor.
2. The emission levels of other frequencies are very lower than the limit and not show in test report.
3. The Aux Factor is a notch filter switch box loss, this item is not used.

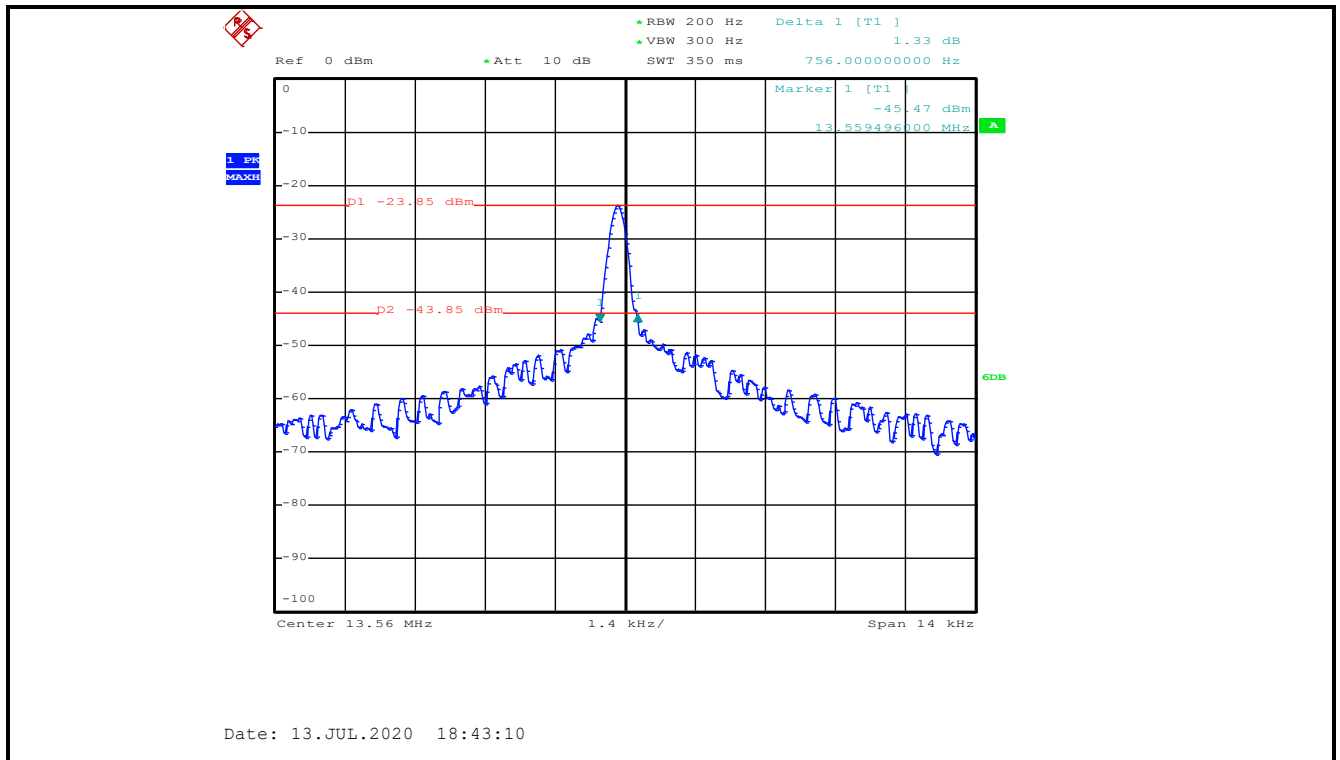
6.3 20dB Bandwidth

Test Requirement:	FCC Part15 C Section 15.215 (c)
Receiver setup:	RBW=200Hz, VBW=300Hz, detector: Peak
Limit:	The fundamental emission be kept within at least the central 80% of the permitted band
Test Procedure:	<ol style="list-style-type: none"> 1. According to the follow Test-setup, keep the relative position between the artificial antenna and the EUT. 2. Set the EUT to proper test channel. 3. Max hold the radiated emissions, mark the peak power frequency point and the -20dB upper and lower frequency points. 4. Read 20dB bandwidth.
Test setup:	 <p>The diagram illustrates the test setup. A Spectrum Analyzer is connected to an E.U.T (Equipment Under Test) via a red cable. Both the Spectrum Analyzer and the E.U.T are placed on a Non-Conducted Table. Below the table is a Ground Reference Plane.</p>
Test Instruments:	Refer to section 5.9 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed

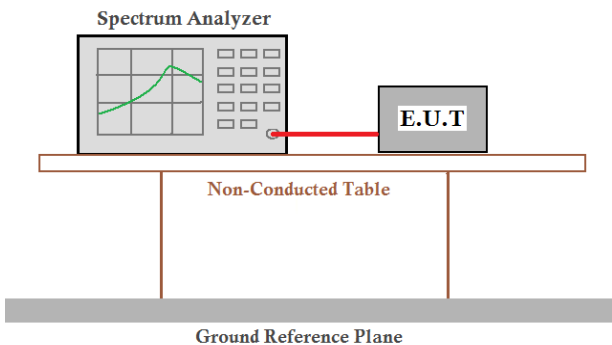
Measurement Data

20dB bandwidth (kHz)	Limit (kHz)	Results
0.756	11.2	Passed
<i>Note: For 13.56MHz, permitted Band is 14 kHz, so the Limit is 11.2 kHz.</i>		

Test plot as follows:



6.4 Frequency Tolerance

Test Requirement:	FCC Part15 C Section 15.225 (e)
Receiver setup:	RBW=200Hz, VBW=300Hz, span=14kHz, detector: Peak
Limit:	±0.01% of the operating frequency
Test mode:	Transmitting mode
Test Procedure:	<p>Frequency stability V.S. Temperature measurement</p> <ol style="list-style-type: none"> 1. The equipment under test was powered by a fresh battery. 2. RF output was connected to spectrum analyzer via feed through attenuators. 3. The EUT was placed inside the temperature chamber. 4. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and measure EUT 20°C operating frequency as reference frequency. 5. Turn EUT off and set the chamber temperature to –20°C. After the temperature stabilized for approximately 30 minutes recorded the frequency. 6. Repeat step measure with 10°C increased per stage until the highest temperature of +50°C reached <p>Frequency stability V.S. Voltage measurement</p> <ol style="list-style-type: none"> 1. Set chamber temperature to 25°C. Use a variable DC power source to power the EUT and set the voltage to rated voltage. 2. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and recorded the frequency. <p>Reduce the input voltage to specify extreme voltage variation (+/- 15%) and endpoint, record the maximum frequency change.</p>
Test setup:	 <p>The diagram illustrates the test setup. A Spectrum Analyzer is connected to an E.U.T. (Equipment Under Test) via a red cable. Both the Spectrum Analyzer and the E.U.T. are placed on a Non-Conducted Table. The table is supported by two vertical legs and sits on a Ground Reference Plane.</p>
Test Instruments:	Refer to section 5.9 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed

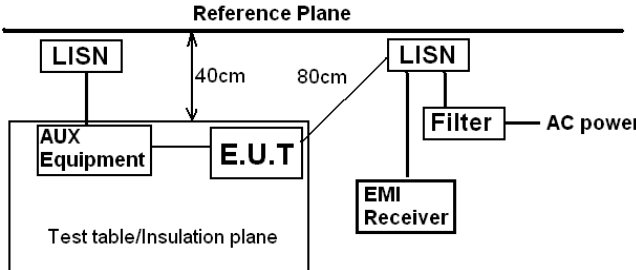
Measurement Data:**a) Frequency stability V.S. Temperature measurement**

Voltage (Vdc)	Temperature (°C)	Frequency Tolerance (Hz)	Frequency Error (%)	Limit (%)	Results
12.0	-20	200	0.0015	±0.01	Pass
	-10	168	0.0012	±0.01	Pass
	0	173	0.0013	±0.01	Pass
	+10	186	0.0014	±0.01	Pass
	+20	184	0.0014	±0.01	Pass
	+30	178	0.0013	±0.01	Pass
	+40	183	0.0013	±0.01	Pass
	+50	194	0.0014	±0.01	Pass

b) Frequency stability V.S. Voltage measurement

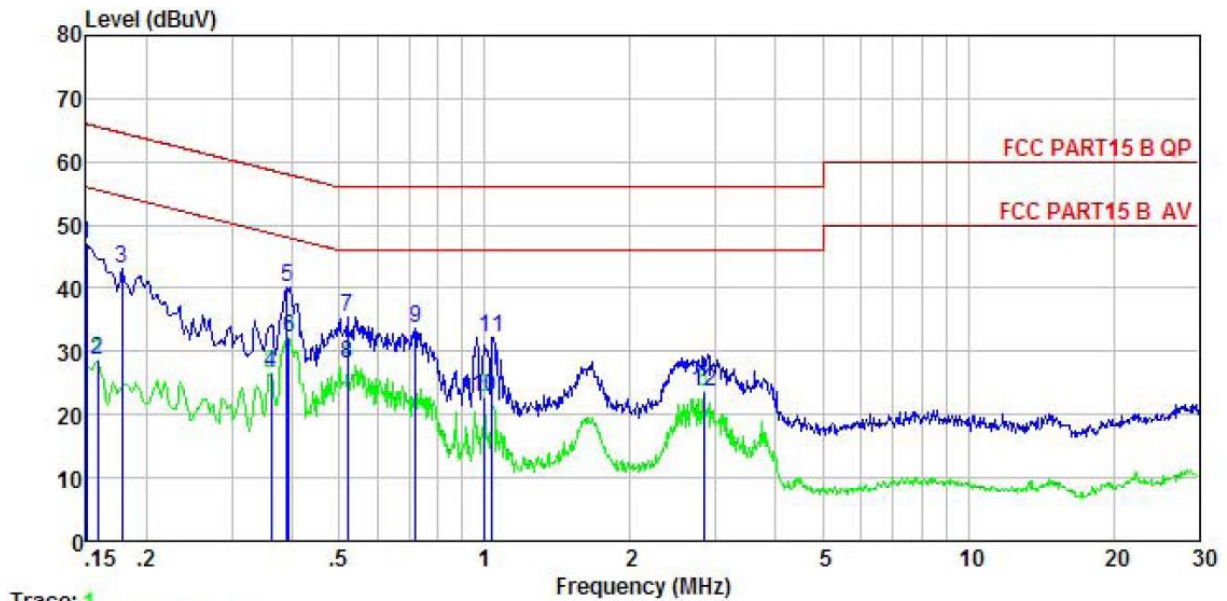
Temperature (°C)	Voltage (Vdc)	Frequency Tolerance (Hz)	Frequency Error (%)	Limit (%)	Results
12.0	10.2	198	0.0015	±0.01	Pass
	12.0	175	0.0013	±0.01	Pass
	13.8	183	0.0013	±0.01	Pass

6.5 Conducted Emission

Test Requirement:	FCC Part15 B Section 15.207		
Test Frequency Range:	150kHz to 30MHz		
Class / Severity:	Class B		
Receiver setup:	RBW=9kHz, VBW=30kHz		
Limit:	Frequency range (MHz)	Limit (dBμV)	
		Quasi-peak	Average
	0.15-0.5	66 to 56*	56 to 46*
	0.5-5	56	46
	0.5-30	60	50
* Decreases with the logarithm of the frequency.			
Test setup:	 <p>Remark: E.U.T: Equipment Under Test LISN: Line Impedance Stabilization Network Test table height=0.8m</p>		
Test procedure	<ol style="list-style-type: none"> 1. The E.U.T and simulators are connected to the main power through a line impedance stabilization network (L.I.S.N.).It provide a 50ohm/50uH coupling impedance for the measuring equipment. 2. The peripheral devices are also connected to the main power through a LISN that provides a 50ohm/50uH coupling impedance with 50ohm termination. (Please refer to the block diagram of the test setup and photographs). 3. Both sides of A.C. line are checked for maximum conducted interference. In order to find the maximum emission, the relative positions of equipment and all of the interface cables must be changed according to ANSI C63.10(latest version) on conducted measurement. 		
Test Instruments:	Refer to section 5.9 for details		
Test mode:	Refer to section 5.3 for details		
Test results:	Pass		

Measurement Data:

Product name:	BA8200-T	Product model:	BA8200-T
Test by:	Yaro	Test mode:	RFID Tx mode
Test frequency:	150 kHz ~ 30 MHz	Phase:	Line
Test voltage:	AC 120 V/60 Hz	Environment:	Temp: 22.5°C Humi: 55%



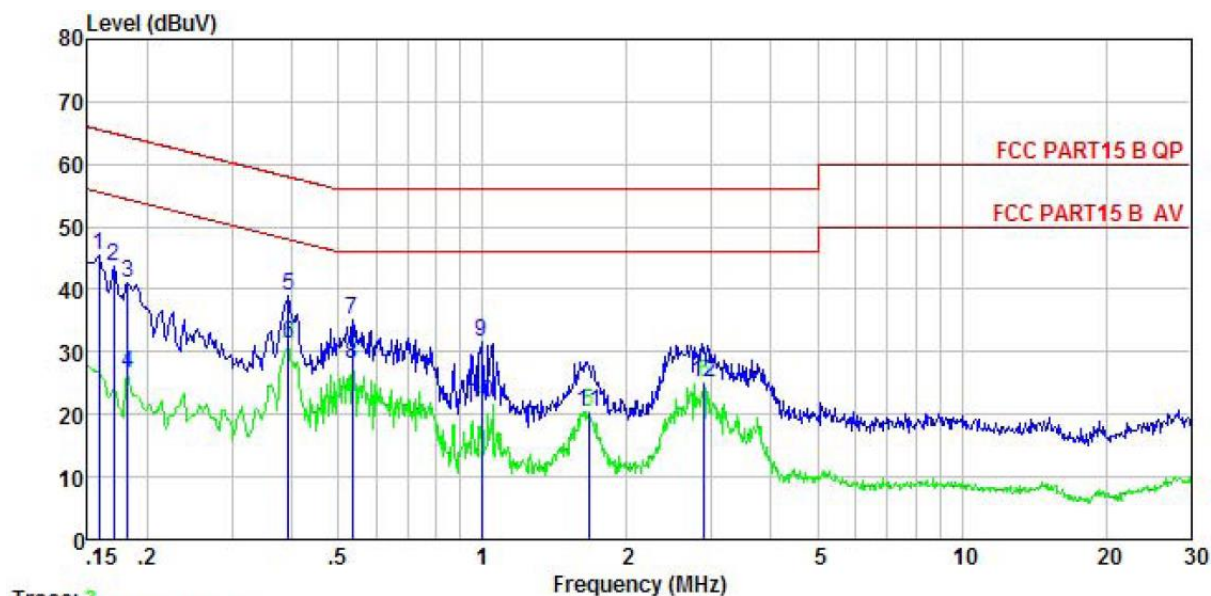
Trace: 1

	Freq	Read Level	LISN Factor	Cable Loss	Level	Limit Line	Over Limit	Remark
	MHz	dBuV	dB	dB	dBuV	dBuV	dB	
1	0.150	36.56	-0.45	10.78	46.89	66.00	-19.11	QP
2	0.158	18.33	-0.44	10.77	28.66	55.56	-26.90	Average
3	0.178	32.74	-0.43	10.77	43.08	64.59	-21.51	QP
4	0.361	16.08	-0.38	10.73	26.43	48.69	-22.26	Average
5	0.389	29.79	-0.37	10.72	40.14	58.08	-17.94	QP
6	0.393	21.97	-0.37	10.72	32.32	47.99	-15.67	Average
7	0.521	25.14	-0.39	10.76	35.51	56.00	-20.49	QP
8	0.521	17.59	-0.39	10.76	27.96	46.00	-18.04	Average
9	0.720	23.38	-0.38	10.78	33.78	56.00	-22.22	QP
10	1.000	12.29	-0.38	10.87	22.78	46.00	-23.22	Average
11	1.032	21.82	-0.38	10.87	32.31	56.00	-23.69	QP
12	2.839	13.17	-0.44	10.93	23.66	46.00	-22.34	Average

Notes:

1. An initial pre-scan was performed on the line and neutral lines with peak detector.
2. Quasi-Peak and Average measurement were performed at the frequencies with maximized peak emission.
3. Final Level=Receiver Read level + LISN Factor + Cable Loss.

Product name:	BA8200-T	Product model:	BA8200-T
Test by:	Yaro	Test mode:	RFID Tx mode
Test frequency:	150 kHz ~ 30 MHz	Phase:	Neutral
Test voltage:	AC 120 V/60 Hz	Environment:	Temp: 22.5℃ Humi: 55%



	Freq	Read	LISN	Cable	Level	Limit	Over	
	MHz	Level	Factor	Loss	Level	Line	Limit	Remark
	MHz	dBuV	dB	dB	dBuV	dBuV	dB	
1	0.158	35.27	-0.68	10.77	45.36	65.56	-20.20	QP
2	0.170	33.62	-0.68	10.77	43.71	64.94	-21.23	QP
3	0.182	30.97	-0.69	10.77	41.05	64.42	-23.37	QP
4	0.182	16.38	-0.69	10.77	26.46	54.42	-27.96	Average
5	0.393	28.84	-0.64	10.72	38.92	57.99	-19.07	QP
6	0.393	21.14	-0.64	10.72	31.22	47.99	-16.77	Average
7	0.535	24.88	-0.65	10.76	34.99	56.00	-21.01	QP
8	0.535	17.83	-0.65	10.76	27.94	46.00	-18.06	Average
9	0.994	21.42	-0.63	10.87	31.66	56.00	-24.34	QP
10	1.000	11.60	-0.63	10.87	21.84	46.00	-24.16	Average
11	1.662	10.22	-0.66	10.94	20.50	46.00	-25.50	Average
12	2.900	14.84	-0.67	10.92	25.09	46.00	-20.91	Average

Notes:

1. An initial pre-scan was performed on the line and neutral lines with peak detector.
2. Quasi-Peak and Average measurement were performed at the frequencies with maximized peak emission.
3. Final Level = Receiver Read level + LISN Factor + Cable Loss.